ispLSI® and pLSI® 1016

High-Density Programmable Logic

Features

- **HIGH-DENSITY PROGRAMMABLE LOGIC**
  - — High-Speed Global Interconnect
  - — 2000 PLD Gates
  - — 32 I/O Pins, Four Dedicated Inputs
  - — 96 Registers
  - — Wide Input Gating for Fast Counters, State Machines, Address Decoders, etc.
  - — Small Logic Block Size for Random Logic
  - — Security Cell Prevents Unauthorized Copying
- **HIGH PERFORMANCE E²CMOS® TECHNOLOGY**
  - — fmax = 110 MHz Maximum Operating Frequency
  - — fmax = 60 MHz for Industrial and Military/883 Devices
  - — tpd = 10 ns Propagation Delay
  - — TTL Compatible Inputs and Outputs
  - — Electrically Erasable and Reprogrammable
  - — Non-Volatile E²CMOS Technology
  - — 100% Tested
- **ispLSI OFFERS THE FOLLOWING ADDED FEATURES**
  - — In-System Programmable™ (ISP™) 5-Volt Only
  - — Increased Manufacturing Yields, Reduced Time-to-Market, and Improved Product Quality
  - — Reprogram Soldered Devices for Faster Debugging
- **COMBINES EASE OF USE AND THE FAST SYSTEM SPEED OF PLDs WITH THE DENSITY AND FLEXIBILITY OF FIELD PROGRAMMABLE GATE ARRAYS**
  - — Complete Programmable Device Can Combine Glue Logic and Structured Designs
  - — Three Dedicated Clock Input Pins
  - — Synchronous and Asynchronous Clocks
  - — Flexible Pin Placement
  - — Optimized Global Routing Pool Provides Global Interconnectivity
- **ispLSI DEVELOPMENT TOOLS**

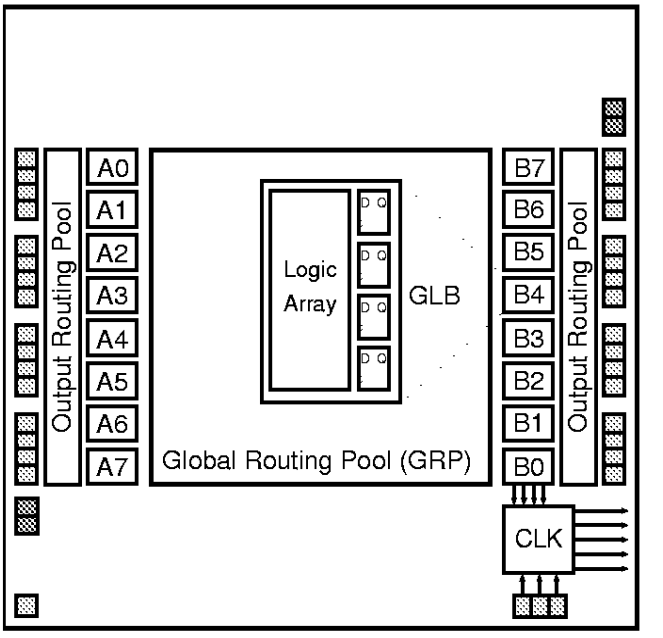
  ispVHDL™ Systems
  - — VHDL/Verilog-HDL/Schematic Design Options
  - — Functional/Timing/VHDL Simulation Options

  ispDS™ Software
  - — Lattice HDL or Boolean Logic Entry
  - — Functional Simulator and Waveform Viewer

  ispDS+™ HDL Synthesis-Optimized Logic Fitter
  - — Supports Leading Third-Party Design Environments for Schematic Capture, Synthesis and Timing Simulation
  - — Static Timing Analyzer

  ISP Daisy Chain Download Software

Functional Block Diagram



Description

The ispLSI and pLSI 1016 are High-Density Programmable Logic Devices containing 96 Registers, 32 Universal I/O pins, four Dedicated Input pins, three Dedicated Clock Input pins and a Global Routing Pool (GRP). The GRP provides complete interconnectivity between all of these elements. The ispLSI 1016 features 5-Volt in-system programming and in-system diagnostic capabilities. It is the first device which offers non-volatile reprogrammability of the logic, as well as the interconnect to provide truly reconfigurable systems. It is architecturally and parametrically compatible to the pLSI 1016 device, but multiplexes four input pins to control in-system programming.

The basic unit of logic on the ispLSI and pLSI 1016 devices is the Generic Logic Block (GLB). The GLBs are labeled A0, A1 .. B7 (see figure 1). There are a total of 16 GLBs in the ispLSI and pLSI 1016 devices. Each GLB has 18 inputs, a programmable AND/OR/XOR array, and four outputs which can be configured to be either combinatorial or registered. Inputs to the GLB come from the GRP and dedicated inputs. All of the GLB outputs are brought back into the GRP so that they can be connected to the inputs of any other GLB on the device.

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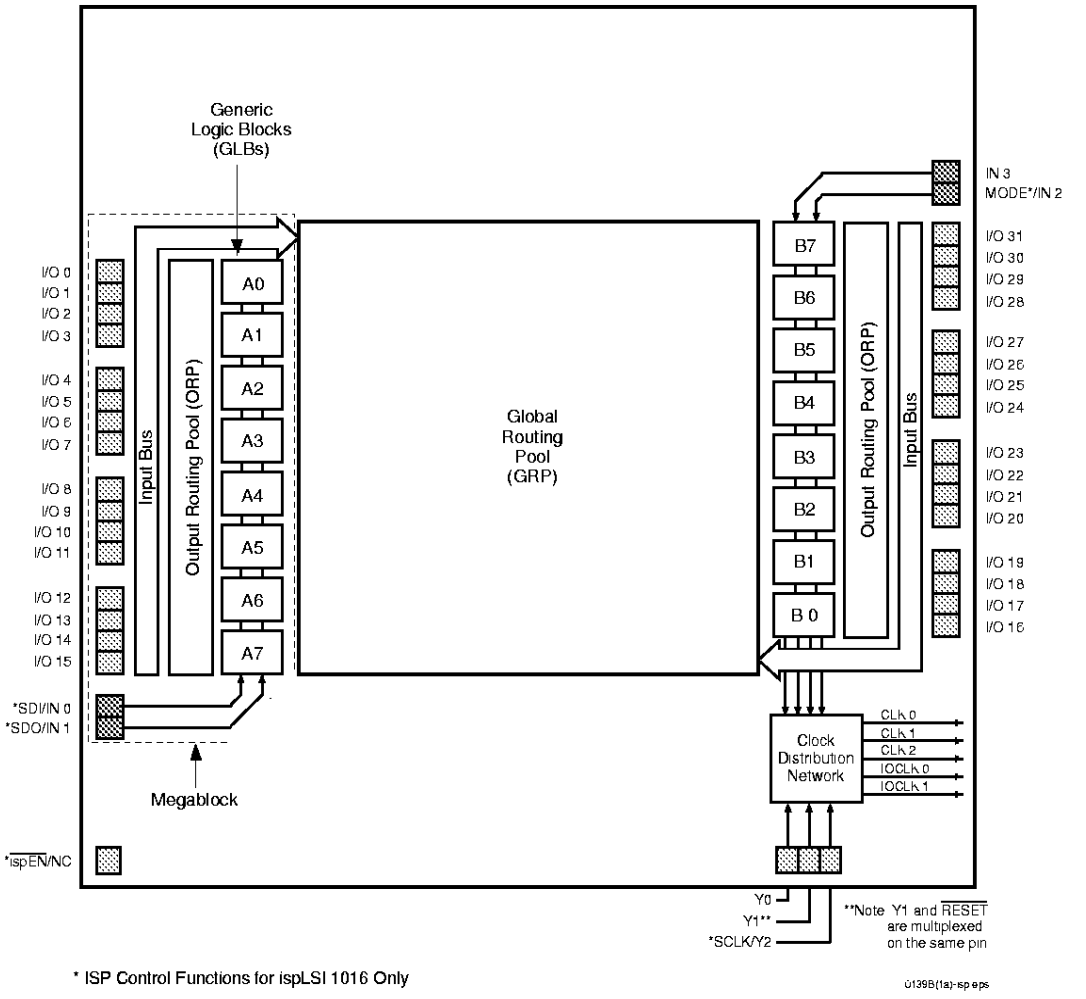
December 1997

Functional Block Diagram

Figure 1. ispLSI and pLSI 1016 Functional Block Diagram



The devices also have 32 I/O cells, each of which is directly connected to an I/O pin. Each I/O cell can be individually programmed to be a combinatorial input, registered input, latched input, output or bi-directional I/O pin with 3-state control. Additionally, all outputs are polarity selectable, active high or active low. The signal levels are TTL compatible voltages and the output drivers can source 4 mA or sink 8 mA.

Eight GLBs, 16 I/O cells, two dedicated inputs and one ORP are connected together to make a Megablock (see figure 1). The outputs of the eight GLBs are connected to a set of 16 universal I/O cells by the ORP. The ispLSI and pLSI 1016 devices contain two of these Megablocks.

The GRP has as its inputs the outputs from all of the GLBs and all of the inputs from the bi-directional I/O cells. All of these signals are made available to the inputs of the GLBs. Delays through the GRP have been equalized to minimize timing skew.

Clocks in the ispLSI and pLSI 1016 devices are selected using the Clock Distribution Network. Three dedicated clock pins (Y0, Y1 and Y2) are brought into the distribution network, and five clock outputs (CLK 0, CLK 1, CLK 2, IOCLK 0 and IOCLK 1) are provided to route clocks to the GLBs and I/O cells. The Clock Distribution Network can also be driven from a special clock GLB (B0 on the ispLSI and pLSI 1016 devices). The logic of this GLB allows the user to create an internal clock from a combination of internal signals within the device.

Absolute Maximum Ratings [1]

Supply Voltage V_{CC} .....-0.5 to +7.0V

Input Voltage Applied..... -2.5 to V_{CC} +1.0V

Off-State Output Voltage Applied ..... -2.5 to V_{CC} +1.0V

Storage Temperature..... -65 to 150°C

Case Temp. with Power Applied ..... -55 to 125°C

Max. Junction Temp. (T_J) with Power Applied ... 150°C

1. Stresses above those listed under the "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation of the device at these or at any other conditions above those indicated in the operational sections of this specification is not implied (while programming, follow the programming specifications).

DC Recommended Operating Conditions

SYMBOL	PARAMETER			MIN.	MAX.	UNITS
V_{CC}	Supply Voltage	Commercial	T_A = 0°C to +70°C	4.75	5.25	V
		Industrial	T_A = -40°C to +85°C	4.5	5.5	
		Military/883	T_C = -55°C to +125°C	4.5	5.5	
V_{IL}	Input Low Voltage			0	0.8	V
V_{IH}	Input High Voltage			2.0	Vcc + 1	V

Table 2- 0005Aisp w/mil eps

Capacitance (T_A=25°C, f=1.0 MHz)

SYMBOL	PARAMETER		MAXIMUM[1]	UNITS	TEST CONDITIONS
C_1	Dedicated Input Capacitance	Commercial/Industrial	8	pf	V_{CC}=5.0V, V_{IN}=2.0V
		Military	10	pf	V_{CC}=5.0V, V_{IN}=2.0V
C_2	I/O and Clock Capacitance		10	pf	V_{CC}=5.0V, $V_{I/O}$, V_Y=2.0V

1. Guaranteed but not 100% tested.

Table 2- 0006

Data Retention Specifications

PARAMETER	MINIMUM	MAXIMUM	UNITS
Data Retention	20	–	Years
ispLSI Erase/Reprogram Cycles	10000	–	Cycles
pLSI Erase/Reprogram Cycles	100	–	Cycles

Table 2- 0008B

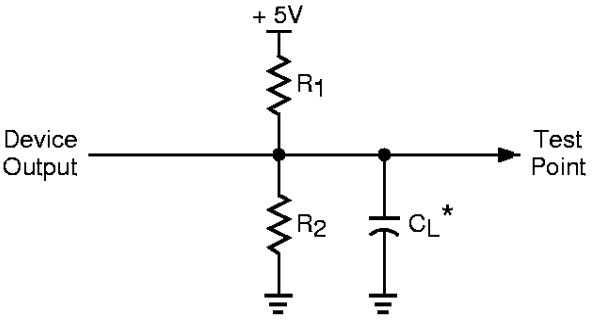
Switching Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise and Fall Time	≤ 3ns 10% to 90%
Input Timing Reference Levels	1.5V
Output Timing Reference Levels	1.5V
Output Load	See figure 2

3-state levels are measured 0.5V from steady-state active level.

Table 2- 0003

Figure 2. Test Load



*C_L includes Test Fixture and Probe Capacitance.

Output Load Conditions (see figure 2)

Test Condition		R1	R2	CL
A		470Ω	390Ω	35pF
B	Active High	∞	390Ω	35pF
	Active Low	470Ω	390Ω	35pF
C	Active High to Z at V_{OH} - 0.5V	∞	390Ω	5pF
	Active Low to Z at V_{OL} + 0.5V	470Ω	390Ω	5pF

Table 2- 0004A

DC Electrical Characteristics

Over Recommended Operating Conditions

SYMBOL	PARAMETER	CONDITION		MIN.	TYP.[3]	MAX.	UNITS
V_{OL}	Output Low Voltage	I_{OL} =8 mA		–	–	0.4	V
V_{OH}	Output High Voltage	I_{OH} =-4 mA		2.4	–	–	V
I_{IL}	Input or I/O Low Leakage Current	$0V \le V_{IN} \le V_{IL}$ (MAX.)		–	–	-10	µA
I_{IH}	Input or I/O High Leakage Current	$3.5V \le V_{IN} \le V_{CC}$		–	–	10	µA
I_{IL-isp}	isp Input Low Leakage Current	$0V \le V_{IN} \le V_{IL}$ (MAX.)		–	–	-150	µA
I_{IL-PU}	I/O Active Pull-Up Current	$0V \le V_{IN} \le V_{IL}$		–	–	-150	µA
I_{OS}[1]	Output Short Circuit Current	V_{CC} = 5V, V_{OUT} = 0.5V		–	–	-200	mA
I_{CC}[2,4]	Operating Power Supply Current	V_{IL} = 0.5V, V_{IH} = 3.0V	Commercial	–	100	150	mA
		f_{TOGGLE} = 1 MHz	Industrial/Military	–	100	170	mA

1. One output at a time for a maximum duration of one second. V_{out} = 0.5V was selected to avoid test problems by tester ground degradation. Characterized but not 100% tested.
2. Measured using four 16-bit counters.
3. Typical values are at V_{CC} = 5V and T_A = 25°C.
4. Maximum I_{CC} varies widely with specific device configuration and operating frequency. Refer to the Power Consumption section of this datasheet and Thermal Management section of the Lattice Semiconductor Data Book or CD-ROM to estimate maximum I_{CC}.

Table 2-0007A-16 w/mil

External Timing Parameters

Over Recommended Operating Conditions

PARAMETER	TEST COND.[5]	#[2]	DESCRIPTION[1]	-110		-90		UNITS
				MIN.	MAX.	MIN.	MAX.	
t_{pd1}	A	1	Data Propagation Delay, 4PT bypass, ORP bypass	–	10	–	12	ns
t_{pd2}	A	2	Data Propagation Delay, Worst Case Path	–	14.5	–	17	ns
f_{max} (Int.)	A	3	Clock Frequency with Internal Feedback[3]	111	–	90.9	–	MHz
f_{max} (Ext.)	–	4	Clock Frequency with External Feedback $\left(\frac{1}{tsu2 + tco1}\right)$	70.1	–	58.8	–	MHz
f_{max} (Tog.)	–	5	Clock Frequency, Max Toggle[4]	125	–	125	–	MHz
t_{su1}	–	6	GLB Reg. Setup Time before Clock, 4PT bypass	4.5	–	6	–	ns
t_{co1}	A	7	GLB Reg. Clock to Output Delay, ORP bypass	–	7	–	8	ns
t_{h1}	–	8	GLB Reg. Hold Time after Clock, 4 PT bypass	0	–	0	–	ns
t_{su2}	–	9	GLB Reg. Setup Time before Clock	7.5	–	9	–	ns
t_{co2}	–	10	GLB Reg. Clock to Output Delay	–	8.5	–	10	ns
t_{h2}	–	11	GLB Reg. Hold Time after Clock	0	–	0	–	ns
t_{r1}	A	12	Ext. Reset Pin to Output Delay	–	14	–	15	ns
t_{rw1}	–	13	Ext. Reset Pulse Duration	10	–	10	–	ns
t_{en}	B	14	Input to Output Enable	–	15	–	15	ns
t_{dis}	C	15	Input to Output Disable	–	15	–	15	ns
t_{wh}	–	16	Ext. Sync. Clock Pulse Duration, High	4	–	4	–	ns
t_{wl}	–	17	Ext. Sync. Clock Pulse Duration, Low	4	–	4	–	ns
t_{su5}	–	18	I/O Reg. Setup Time before Ext. Sync. Clock (Y1, Y2)	2	–	2	–	ns
t_{h5}	–	19	I/O Reg. Hold Time after Ext. Sync. Clock (Y1, Y2)	5.5	–	6.5	–	ns

1. Unless noted otherwise, all parameters use a GRP load of 4 GLBs, 20 PTXOR path, ORP and Y0 clock.
2. Refer to Timing Model in this data sheet for further details.
3. Standard 16-Bit loadable counter using GRP feedback.
4. fmax (Toggle) may be less than 1/(twh + twl). This is to allow for a clock duty cycle of other than 50%.
5. Reference Switching Test Conditions Section.

Table 2-0030-16/110,90C

External Timing Parameters

Over Recommended Operating Conditions

PARAMETER	TEST COND.[5]	#[2]	DESCRIPTION[1]	-80		-60		UNITS
				MIN.	MAX.	MIN.	MAX.	
t_{pd1}	A	1	Data Propagation Delay, 4PT bypass, ORP bypass	–	15	–	20	ns
t_{pd2}	A	2	Data Propagation Delay, Worst Case Path	–	20	–	25	ns
f_{max} (Int.)	A	3	Clock Frequency with Internal Feedback[3]	80	–	60	–	MHz
f_{max} (Ext.)	–	4	Clock Frequency with External Feedback $\left(\frac{1}{t_{su2} + t_{co1}}\right)$	50	–	38	–	MHz
f_{max} (Tog.)	–	5	Clock Frequency, Max Toggle[4]	100	–	83	–	MHz
t_{su1}	–	6	GLB Reg. Setup Time before Clock, 4PT bypass	7	–	9	–	ns
t_{co1}	A	7	GLB Reg. Clock to Output Delay, ORP bypass	–	10	–	13	ns
t_{h1}	–	8	GLB Reg. Hold Time after Clock, 4 PT bypass	0	–	0	–	ns
t_{su2}	–	9	GLB Reg. Setup Time before Clock	10	–	13	–	ns
t_{co2}	–	10	GLB Reg. Clock to Output Delay	–	12	–	16	ns
t_{h2}	–	11	GLB Reg. Hold Time after Clock	0	–	0	–	ns
t_{r1}	A	12	Ext. Reset Pin to Output Delay	–	17	–	22.5	ns
t_{rw1}	–	13	Ext. Reset Pulse Duration	10	–	13	–	ns
t_{en}	B	14	Input to Output Enable	–	18	–	24	ns
t_{dis}	C	15	Input to Output Disable	–	18	–	24	ns
t_{wh}	–	16	Ext. Sync. Clock Pulse Duration, High	5	–	6	–	ns
t_{wl}	–	17	Ext. Sync. Clock Pulse Duration, Low	5	–	6	–	ns
t_{su5}	–	18	I/O Reg. Setup Time before Ext. Sync. Clock (Y1, Y2)	2	–	2.5	–	ns
t_{h5}	–	19	I/O Reg. Hold Time after Ext. Sync. Clock (Y1, Y2)	6.5	–	8.5	–	ns

Table 2-0030-16/80,60C

1. Unless noted otherwise, all parameters use a GRP load of 4 GLBs, 20 PTXOR path, ORP and Y0 clock.
2. Refer to Timing Model in this data sheet for further details.
3. Standard 16-Bit loadable counter using GRP feedback.
4. fmax (Toggle) may be less than 1/(twh + twl). This is to allow for a clock duty cycle of other than 50%.
5. Reference Switching Test Conditions Section.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-110		-90		UNITS
			MIN.	MAX.	MIN.	MAX.	
Inputs							
t_{iobp}	20	I/O Register Bypass	–	0.8	–	1.0	ns
t_{iolat}	21	I/O Latch Delay	–	1.7	–	2.0	ns
t_{iosu}	22	I/O Register Setup Time before Clock	4.1	–	4.5	–	ns
t_{ioh}	23	I/O Register Hold Time after Clock	1.8	–	2.0	–	ns
t_{ioco}	24	I/O Register Clock to Out Delay	–	1.7	–	2.0	ns
t_{ior}	25	I/O Register Reset to Out Delay	–	2.1	–	2.5	ns
t_{din}	26	Dedicated Input Delay	–	1.7	–	2.0	ns
GRP							
t_{grp1}	27	GRP Delay, 1 GLB Load	–	0.6	–	0.7	ns
t_{grp4}	28	GRP Delay, 4 GLB Loads	–	0.8	–	1.0	ns
t_{grp8}	29	GRP Delay, 8 GLB Loads	–	1.5	–	1.8	ns
t_{grp12}	30	GRP Delay, 12 GLB Loads	–	2.1	–	2.6	ns
t_{grp16}	31	GRP Delay, 16 GLB Loads	–	2.8	–	3.4	ns
GLB							
t_{4ptbp}	33	4 Product Term Bypass Path Delay	–	5.3	–	6.5	ns
t_{1ptxor}	34	1 Product Term/XOR Path Delay	–	6.1	–	7.0	ns
$t_{20ptxor}$	35	20 Product Term/XOR Path Delay	–	6.6	–	8.0	ns
t_{xoradj}	36	XOR Adjacent Path Delay[3]	–	8.2	–	9.5	ns
t_{gbp}	37	GLB Register Bypass Delay	–	0.5	–	0.5	ns
t_{gsu}	38	GLB Register Setup Time before Clock	0.3	–	1.0	–	ns
t_{gh}	39	GLB Register Hold Time after Clock	2.9	–	3.5	–	ns
t_{gco}	40	GLB Register Clock to Output Delay	–	1.6	–	1.5	ns
t_{gr}	41	GLB Register Reset to Output Delay	–	2.1	–	2.5	ns
t_{ptre}	42	GLB Product Term Reset to Register Delay	–	8.2	–	10.0	ns
t_{ptoe}	43	GLB Product Term Output Enable to I/O Cell Delay	–	9.0	–	9.0	ns
t_{ptck}	44	GLB Product Term Clock Delay	2.8	6.2	3.5	7.5	ns
ORP							
t_{orp}	45	ORP Delay	–	2.0	–	2.5	ns
t_{orpbp}	46	ORP Bypass Delay	–	0.4	–	0.5	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.
3. The XOR Adjacent path can only be used by Hard Macros.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-110		-90		UNITS
			MIN.	MAX.	MIN.	MAX.	
Outputs							
t_{ob}	47	Output Buffer Delay	–	2.1	–	2.5	ns
t_{oen}	48	I/O Cell OE to Output Enabled	–	3.3	–	4.0	ns
t_{odis}	49	I/O Cell OE to Output Disabled	–	3.3	–	4.0	ns
Clocks							
t_{gy0}	50	Clock Delay, Y0 to Global GLB Clock Line (Ref. clock)	2.9	2.9	3.5	3.5	ns
$t_{gy1/2}$	51	Clock Delay, Y1 or Y2 to Global GLB Clock Line	2.1	3.8	2.5	4.5	ns
t_{gcp}	52	Clock Delay, Clock GLB to Global GLB Clock Line	0.8	4.2	1.0	5.0	ns
$t_{ioy1/2}$	53	Clock Delay, Y1 or Y2 to I/O Cell Global Clock Line	2.1	3.8	2.5	4.5	ns
t_{iocp}	54	Clock Delay, Clock GLB to I/O Cell Global Clock Line	0.8	4.2	1.0	5.0	ns
Global Reset							
t_{gr}	55	Global Reset to GLB and I/O Registers	–	7.9	–	7.5	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-80		-60		UNITS
			MIN.	MAX.	MIN.	MAX.	
Inputs							
t_{iobp}	20	I/O Register Bypass	–	2.0	–	2.7	ns
t_{iolat}	21	I/O Latch Delay	–	3.0	–	4.0	ns
t_{iosu}	22	I/O Register Setup Time before Clock	5.5	–	7.3	–	ns
t_{ioh}	23	I/O Register Hold Time after Clock	1.0	–	1.3	–	ns
t_{ioco}	24	I/O Register Clock to Out Delay	–	3.0	–	4.0	ns
t_{ior}	25	I/O Register Reset to Out Delay	–	2.5	–	3.3	ns
t_{din}	26	Dedicated Input Delay	–	4.0	–	5.3	ns
GRP							
t_{grp1}	27	GRP Delay, 1 GLB Load	–	1.5	–	2.0	ns
t_{grp4}	28	GRP Delay, 4 GLB Loads	–	2.0	–	2.7	ns
t_{grp8}	29	GRP Delay, 8 GLB Loads	–	3.0	–	4.0	ns
t_{grp12}	30	GRP Delay, 12 GLB Loads	–	3.8	–	5.0	ns
t_{grp16}	31	GRP Delay, 16 GLB Loads	–	4.5	–	6.0	ns
GLB							
t_{4ptbp}	33	4 Product Term Bypass Path Delay	–	6.5	–	8.6	ns
t_{1ptxor}	34	1 Product Term/XOR Path Delay	–	7.0	–	9.3	ns
$t_{20ptxor}$	35	20 Product Term/XOR Path Delay	–	8.0	–	10.6	ns
t_{xoradj}	36	XOR Adjacent Path Delay[3]	–	9.5	–	12.7	ns
t_{gbp}	37	GLB Register Bypass Delay	–	1.0	–	1.3	ns
t_{gsu}	38	GLB Register Setup Time before Clock	1.0	–	1.3	–	ns
t_{gh}	39	GLB Register Hold Time after Clock	4.5	–	6.0	–	ns
t_{gco}	40	GLB Register Clock to Output Delay	–	2.0	–	2.7	ns
t_{gr}	41	GLB Register Reset to Output Delay	–	2.5	–	3.3	ns
t_{ptre}	42	GLB Product Term Reset to Register Delay	–	10.0	–	13.3	ns
t_{ptoe}	43	GLB Product Term Output Enable to I/O Cell Delay	–	9.0	–	12.0	ns
t_{ptck}	44	GLB Product Term Clock Delay	3.5	7.5	4.6	9.9	ns
ORP							
t_{orp}	45	ORP Delay	–	2.5	–	3.3	ns
t_{orpbp}	46	ORP Bypass Delay	–	0.5	–	0.7	ns

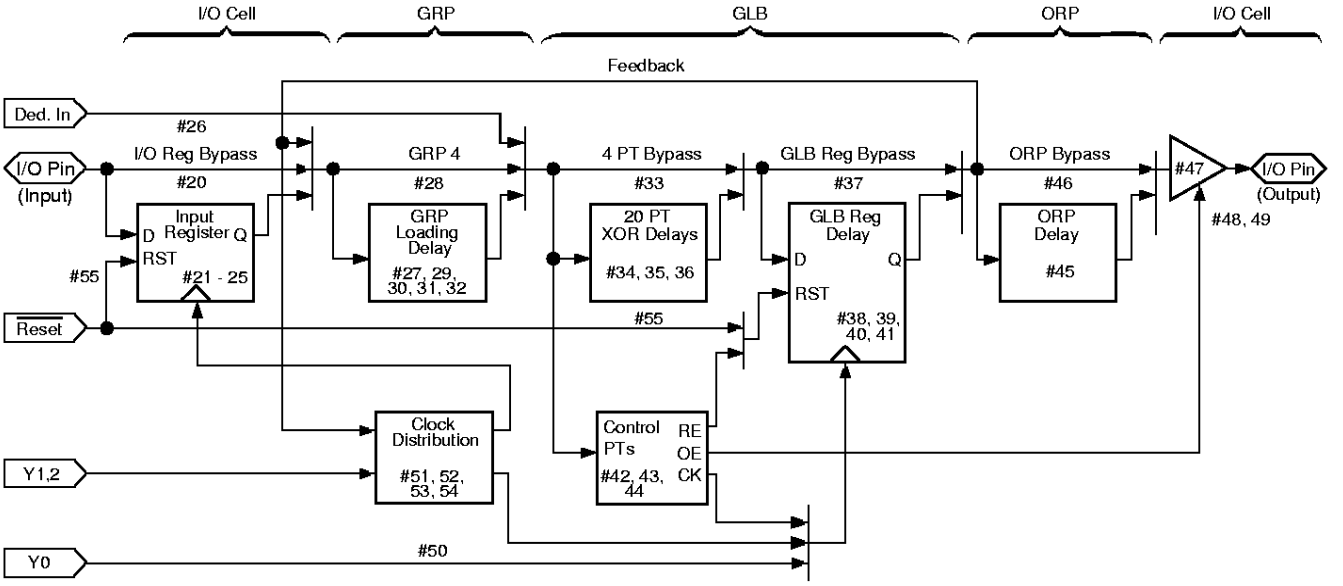
1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.
3. The XOR Adjacent path can only be used by Hard Macros.

Internal Timing Parameters[1]

PARAMETER	#[2]	DESCRIPTION	-80		-60		UNITS
			MIN.	MAX.	MIN.	MAX.	
Outputs							
t_{ob}	47	Output Buffer Delay	–	3.0	–	4.0	ns
t_{oen}	48	I/O Cell OE to Output Enabled	–	5.0	–	6.7	ns
t_{odis}	49	I/O Cell OE to Output Disabled	–	5.0	–	6.7	ns
Clocks							
t_{gy0}	50	Clock Delay, Y0 to Global GLB Clock Line (Ref. clock)	4.5	4.5	6.0	6.0	ns
$t_{gy1/2}$	51	Clock Delay, Y1 or Y2 to Global GLB Clock Line	3.5	5.5	4.6	7.3	ns
t_{gcp}	52	Clock Delay, Clock GLB to Global GLB Clock Line	1.0	5.0	1.3	6.6	ns
$t_{ioy1/2}$	53	Clock Delay, Y1 or Y2 to I/O Cell Global Clock Line	3.5	5.5	4.6	7.3	ns
t_{iocp}	54	Clock Delay, Clock GLB to I/O Cell Global Clock Line	1.0	5.0	1.3	6.6	ns
Global Reset							
t_{gr}	55	Global Reset to GLB and I/O Registers	–	9.0	–	12.0	ns

1. Internal Timing Parameters are not tested and are for reference only.
2. Refer to Timing Model in this data sheet for further details.

ispLSI and pLSI 1016 Timing Model



Derivations of tsu, th and tco from the Product Term Clock[1]

tsu = Logic + Reg su - Clock (min)
= (tiobp + tgrp4 + t20ptxor) + (tgsu) - (tiobp + tgrp4 + tptck(min))
= (#20 + #28 + #35) + (#38) - (#20 + #28 + #44)
5.5 ns = (1.0 + 1.0 + 8.0) + (1.0) - (1.0 + 1.0 + 3.5)

th = Clock (max) + Reg h - Logic
= (tiobp + tgrp4 + tptck(max)) + (tgh) - (tiobp + tgrp4 + t20ptxor)
= (#20 + #28 + #44) + (#39) - (#20 + #28 + #35)
3.0 ns = (1.0 + 1.0 + 7.5) + (3.5) - (1.0 + 1.0 + 8.0)

tco = Clock (max) + Reg co + Output
= (tiobp + tgrp4 + tptck(max)) + (tgco) + (torp + tob)
= (#20 + #28 + #44) + (#40) + (#45 + #47)
16.0 ns = (1.0+ 1.0 +7.5) + (1.5) + (2.5 + 2.5)

Derivations of tsu, th and tco from the Clock GLB[1]

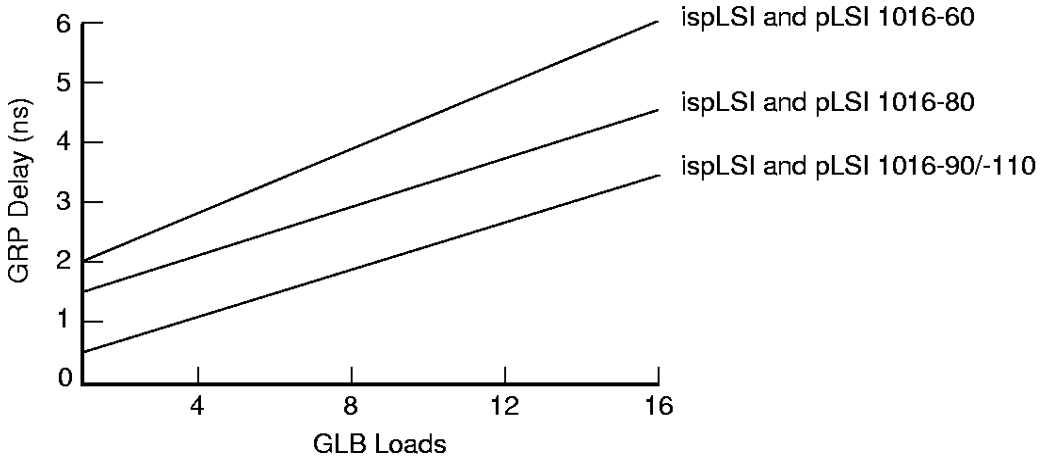
tsu = Logic + Reg su - Clock (min)
= (tiobp + tgrp4 + t20ptxor) + (tgsu) - (tgy0(min) + tgco + tgcp(min))
= (#20 + #28 + #35) + (#38) - (#50 + #40 + #52)
5.0 ns = (1.0 + 1.0 + 8.0) + (1.0) - (3.5 + 1.5 + 1.0)

th = Clock (max) + Reg h - Logic
= (tgy0(max) + tgco + tgcp(max)) + (tgh) - (tiobp + tgrp4 + t20ptxor)
= (#50 + #40 + #52) + (#39) - (#20 + #28 + #35)
3.5 ns = (3.5 + 1.5 + 5.0) + (3.5) - (1.0 + 1.0 + 8.0)

tco = Clock (max) + Reg co + Output
= (tgy0(max) + tgco + tgcp(max)) + (tgco) + (torp + tob)
= (#50 + #40 + #52) + (#40) + (#45 + #47)
16.5 ns = (3.5 + 1.5 + 5.0) + (1.5) + (2.5 + 2.5)

1. Calculations are based upon timing specifications for the ispLSI and pLSI 1016-90.

Maximum GRP Delay vs GLB Loads

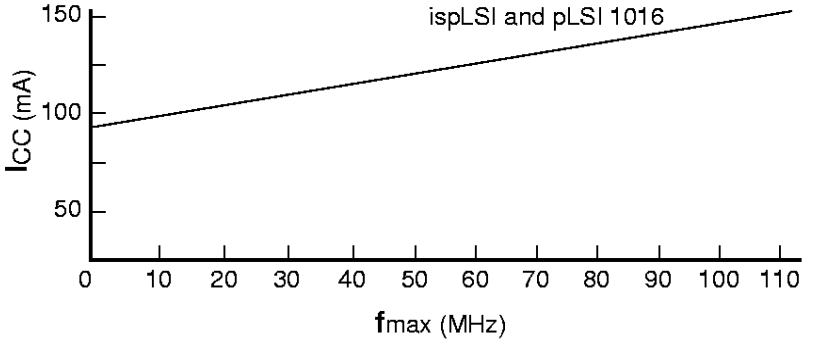


0126A-80-16-isp.eps

Power Consumption

Power consumption in the ispLSI and pLSI 1016 device depends on two primary factors: the speed at which the device is operating, and the number of Product Terms used. Figure 3 shows the relationship between power and operating speed.

Figure 3. Typical Device Power Consumption vs fmax



Notes: Configuration of Four 16-bit Counters
Typical Current at 5V, 25˚C

I_{CC} can be estimated for the ispLSI and pLSI 1016 using the following equation:

I_{CC} = 31 + (# of PTs * 0.45) + (# of nets * Max. freq * 0.009) where:
# of PTs = Number of Product Terms used in design
# of nets = Number of Signals used in device
Max. freq = Highest Clock Frequency to the device

The I_{CC} estimate is based on typical conditions (V_{CC} = 5.0V, room temperature) and an assumption of 2 GLB loads on average exists. These values are for estimates only. Since the value of I_{CC} is sensitive to operating conditions and the program in the device, the actual I_{CC} should be verified.

Pin Description

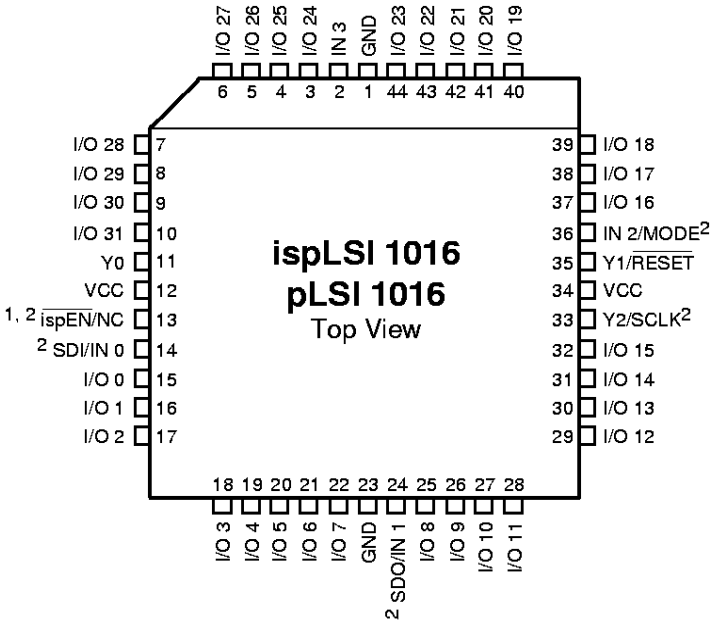
NAME	PLCC PIN NUMBERS	TQFP PIN NUMBERS	JLCC PIN NUMBERS	DESCRIPTION
I/O 0 - I/O 3 I/O 4 - I/O 7 I/O 8 - I/O 11 I/O 12 - I/O 15 I/O 16 - I/O 19 I/O 20 - I/O 23 I/O 24 - I/O 27 I/O 28 - I/O 31	15, 16, 17, 18, 19, 20, 21, 22, 25, 26, 27, 28, 29, 30, 31, 32, 37, 38, 39, 40, 41, 42, 43, 44, 3, 4, 5, 6, 7, 8, 9, 10	9, 10, 11, 12, 13, 14, 15, 16, 19, 20, 21, 22, 23, 24, 25, 26, 31, 32, 33, 34, 35, 36, 37, 38, 41, 42, 43, 44, 1, 2, 3, 4	15, 16, 17, 18, 19, 20, 21, 22, 25, 26, 27, 28, 29, 30, 31, 32, 37, 38, 39, 40, 41, 42, 43, 44, 3, 4, 5, 6, 7, 8, 9, 10	Input/Output Pins - These are the general purpose I/O pins used by the logic array.
IN 3	2	40	2	Dedicated input pins to the device.
$\overline{\text{ispEN}}$/NC [1,2]	13	7	13	Input – Dedicated in-system programming enable input pin. This pin is brought low to enable the programming mode. The MODE, SDI, SDO and SCLK options become active.
SDI/IN 0 [2]	14	8	14	Input – This pin performs two functions. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high. When $\overline{\text{ispEN}}$ is logic low, it functions as an input pin to load programming data into the device. SDI/IN 0 also is used as one of the two control pins for the isp state machine.
MODE/IN 2 [2]	36	30	36	Input – This pin performs two functions. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high. When $\overline{\text{ispEN}}$ is logic low, it functions as a pin to control the operation of the isp state machine.
SDO/IN 1 [2]	24	18	24	Input/Output – This pin performs two functions. It is a dedicated input pin when $\overline{\text{ispEN}}$ is logic high. When $\overline{\text{ispEN}}$ is logic low, it functions as an output pin to read serial shift register data.
SCLK/Y2 [2]	33	27	33	Input – This pin performs two functions. It is a dedicated clock input when $\overline{\text{ispEN}}$ is logic high. This clock input is brought into the Clock Distribution Network, and can optionally be routed to any GLB and/or I/O cell on the device. When $\overline{\text{ispEN}}$ is logic low, it functions as a clock pin for the Serial Shift Register.
Y0	11	5	11	Dedicated Clock input. This clock input is connected to one of the clock inputs of all of the GLBs on the device.
Y1/$\overline{\text{RESET}}$	35	29	35	This pin performs two functions: – Dedicated clock input. This clock input is brought into the Clock Distribution Network, and can optionally be routed to any GLB and/or I/O cell on the device. – Active Low (0) Reset pin which resets all of the GLB and I/O registers in the device.
GND VCC	1, 23 12, 34	17, 39 6, 28	1, 23 12, 34	Ground (GND) V_{CC}

1. NC pins are not to be connected to any active signals, Vcc, or GND.
2. Pins have dual function capability for ispLSI 1016 only.

Table 2 - 0002C-16-isp

Pin Configuration

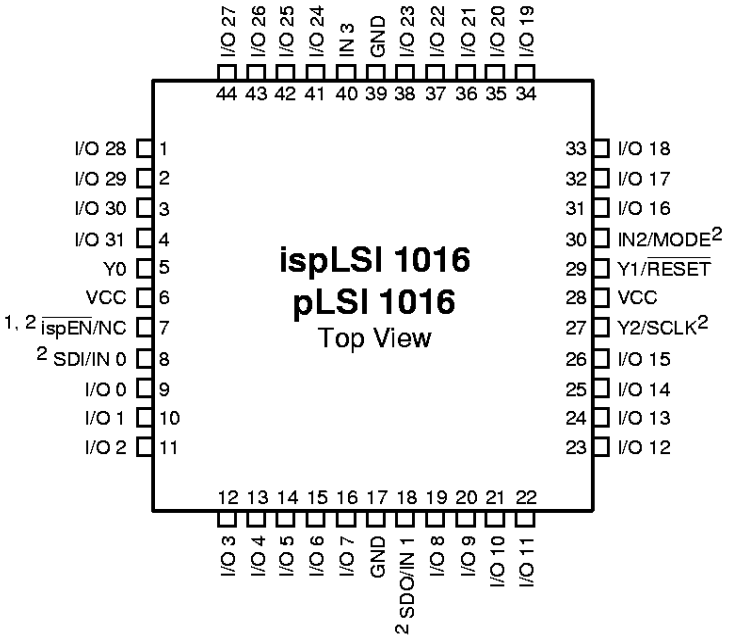
ispLSI and pLSI 1016 44-Pin PLCC Pinout Diagram



1. NC pins are not to be connected to any active signals, Vcc, or GND
2. Pins have dual function capability for ispLSI 1016 only (except pin 13, which is $\overline{\text{ispEN}}$ only).

0123A-isp1016

ispLSI and pLSI 1016 44-Pin TQFP Pinout Diagram

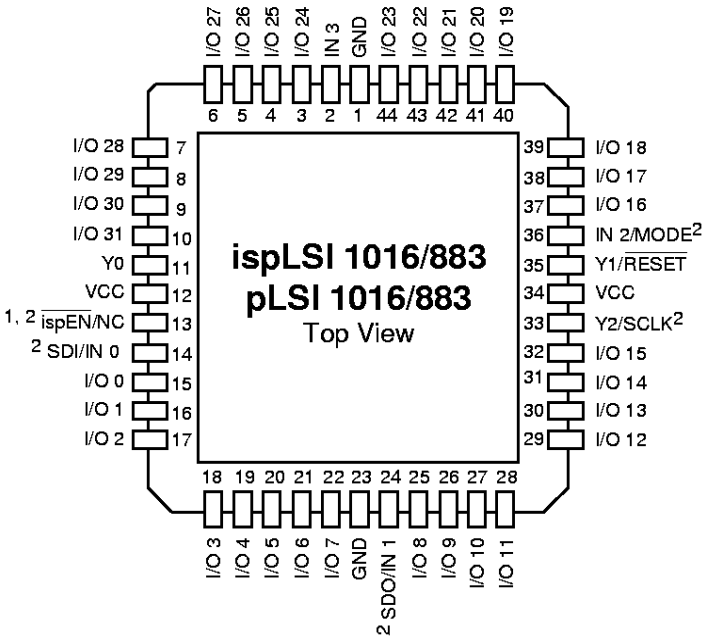


1. NC pins are not to be connected to any active signals, Vcc, or GND
2. Pins have dual function capability for ispLSI 1016 only (except pin 7, which is $\overline{\text{ispEN}}$ only).

0851-16/TQFP

Pin Configuration

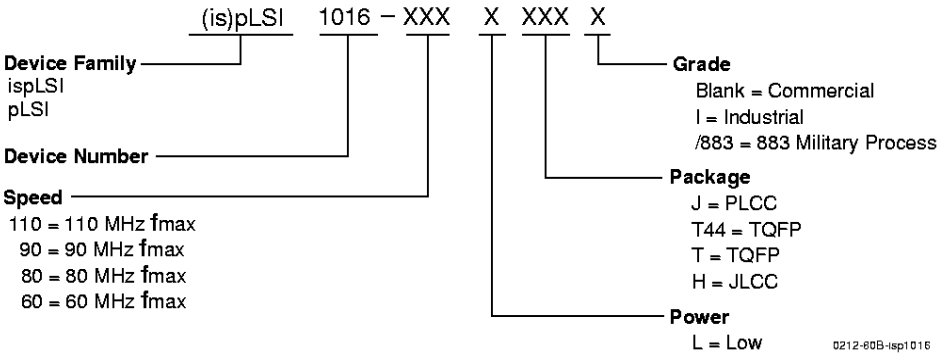
ispLSI and pLSI 1016 44-Pin JLCC Pinout Diagram



1. NC pins are not to be connected to any active signals, Vcc, or GND
2. Pins have dual function capability for ispLSI 1016 only (except pin 13, which is $\overline{\text{ispEN}}$ only).

0123-15-isp/JLCC

Part Number Description



ispLSI and pLSI 1016 Ordering Information

COMMERCIAL

Family	fmax (MHz)	tpd (ns)	Ordering Number	Package
ispLSI	110	10	ispLSI 1016-110LJ	44-Pin PLCC
	90	12	ispLSI 1016-90LJ	44-Pin PLCC
	90	12	ispLSI 1016-90LT44	44-Pin TQFP
	90	12	ispLSI 1016-90LT	44-Pin TQFP
	80	15	ispLSI 1016-80LJ	44-Pin PLCC
	80	15	ispLSI 1016-80LT44	44-Pin TQFP
	80	15	ispLSI 1016-80LT	44-Pin TQFP
	60	20	ispLSI 1016-60LJ	44-Pin PLCC
	60	20	ispLSI 1016-60LT44	44-Pin TQFP
	60	20	ispLSI 1016-60LT	44-Pin TQFP
pLSI	110	10	pLSI 1016-110LJ	44-Pin PLCC
	90	12	pLSI 1016-90LJ	44-Pin PLCC
	90	12	pLSI 1016-90LT44	44-Pin TQFP
	90	12	pLSI 1016-90LT	44-Pin TQFP
	80	15	pLSI 1016-80LJ	44-Pin PLCC
	80	15	pLSI 1016-80LT44	44-Pin TQFP
	80	15	pLSI 1016-80LT	44-Pin TQFP
	60	20	pLSI 1016-60LJ	44-Pin PLCC
	60	20	pLSI 1016-60LT44	44-Pin TQFP
	60	20	pLSI 1016-60LT	44-Pin TQFP

INDUSTRIAL

Family	fmax (MHz)	tpd (ns)	Ordering Number	Package
ispLSI	60	20	ispLSI 1016-60LJI	44-Pin PLCC
	60	20	ispLSI 1016-60LT44I	44-Pin TQFP
pLSI	60	20	pLSI 1016-60LJI	44-Pin PLCC

MILITARY/883

Family	fmax (MHz)	tpd (ns)	Ordering Number	SMD #	Package
ispLSI	60	20	ispLSI 1016-60LH/883	5962-9476201MXC	44-Pin JLCC
pLSI	60	20	pLSI 1016-60LH/883	5962-9476301MXC	44-Pin JLCC

Note: Lattice Semiconductor recognizes the trend in military device procurement towards using SMD compliant devices, as such, ordering by this number is recommended.

Table 2-0041-16-isp1016

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July 1997